





CSD13380F3 SLPS593A - OCTOBER 2016 - REVISED FEBRUARY 2022

CSD13380F3 12-V N-Channel FemtoFET **MOSFET**

1 Features

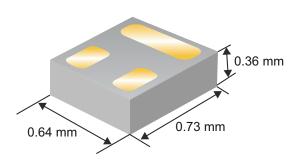
- Low on resistance
- Ultra-low Q_q and Q_{gd}
- High operating drain current
- Ultra-small footprint
 - 0.73 mm × 0.64 mm
- Low profile
 - 0.36-mm max height
- Integrated ESD protection diode
 - Rated > 3-kV HBM
 - Rated > 2-kV CDM
- Lead and halogen free
- RoHS compliant

2 Applications

- Optimized for load switch applications
- Optimized for general purpose switching applications
- **Battery applications**
- Handheld and mobile applications

3 Description

This 63-mΩ, 12-V N-Channel FemtoFET™ MOSFET is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing a substantial reduction in footprint size.



Typical Part Dimensions

Product Summary

T _A = 25°	С	TYPICAL VA	UNIT		
V _{DS}	Drain-to-Source Voltage	12		V	
Qg	Gate Charge Total (4.5 V)		0.91		
Q _{gd}	Gate Charge Gate-to-Drain	e Charge Gate-to-Drain 0.15		nC	
		V _{GS} = 1.8 V 96			
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 2.5 V	73	mΩ	
		V _{GS} = 4.5 V	63		
V _{GS(th)}	Threshold Voltage	0.85		V	

Device Information⁽¹⁾

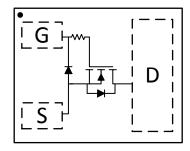
DEVICE	QTY	MEDIA	PACKAGE	SHIP
CSD13380F3	3000		Femto	Таре
CSD13380F3T	250	7-Inch Reel	0.73 mm × 0.64 mm Land Grid Array (LGA)	and Reel

For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

7 to colucto maximum reatings									
T _A = 25	°C (unless otherwise stated)	VALUE	UNIT						
V _{DS}	Drain-to-Source Voltage	12	V						
V_{GS}	Gate-to-Source Voltage	8	V						
	Continuous Drain Current ⁽¹⁾	3.6	Α						
I _D	Continuous Drain Current ⁽²⁾	2.1	^						
I _{DM}	Pulsed Drain Current ^{(2) (3)}	13.5	Α						
n	Power Dissipation ⁽¹⁾	1.4	w						
P_D	Power Dissipation ⁽²⁾	0.5	l vv						
\/	Human-Body Model (HBM)	3	kV						
V _(ESD)	Charged-Device Model (CDM)	2	KV						
T _J , T _{stg}	Operating Junction, Storage Temperature	-55 to 150	°C						

- Max Cu, typical $R_{\theta JA}$ = 90°C/W on 1-in² (6.45-cm²), 2-oz (1) (0.071-mm) thick Cu pad on a 0.06-in (1.52-mm) thick FR4
- Min Cu, typical $R_{\theta JA} = 255$ °C/W. (2)
- Pulse duration ≤ 100 µs, duty cycle ≤ 1%.



Top View



Table of Contents

1 Features1	6 Device and Documentation Support7
2 Applications 1	6.1 Receiving Notification of Documentation Updates7
3 Description	6.2 Trademarks
4 Revision History2	7 Mechanical, Packaging, and Orderable Information8
5 Specifications3	7.1 Mechanical Dimensions
5.1 Electrical Characteristics3	7.2 Recommended Minimum PCB Layout9
5.2 Thermal Information3	7.3 Recommended Stencil Pattern9
5.3 Typical MOSFET Characteristics4	

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision * (October 2016) to Revision A (February 2022)	Page
•	Changed ultra-low profile bullet from 0.35 mm to 0.36 mm in height	1
•	Updated ultra-low profile image height from 0.35 mm to 0.36 mm	1
•	Changed ultra-low profile image height from 0.35 mm to 0.36 mm.	8
	Added FemtoFET Surface Mount Guide note	

5 Specifications

5.1 Electrical Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _{DS} = 250 μA	12			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0 V, V _{DS} = 9.6 V			50	nA
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = 8 V			25	nA
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} , I _{DS} = 250 μA	0.55	0.85	1.30	V
		V _{GS} = 1.8 V, I _{DS} = 0.1 A		96	135	
R _{DS(on)}	Drain-to-source on resistance	V _{GS} = 2.5 V, I _{DS} = 0.4 A		73	92	$m\Omega$
		V _{GS} = 4.5 V, I _{DS} = 0.4 A		63	76	
9 _{fs}	Transconductance	V _{DS} = 1.2 V, I _{DS} = 0.4 A		4.3		S
DYNAMI	C CHARACTERISTICS					
C _{iss}	Input capacitance			120	156	pF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 6 \text{ V},$ $f = 1 \text{ MHz}$		81	105	pF
C _{rss}	Reverse transfer capacitance	, <u>r</u>		9.6	12.5	pF
R _G	Series gate resistance			16		Ω
Qg	Gate charge total (4.5 V)			0.91	1.2	nC
Q _{gd}	Gate charge gate-to-drain	V -6 V L -0 4 A		0.15		nC
Q _{gs}	Gate charge gate-to-source	V _{DS} = 6 V, I _{DS} = 0.4 A		0.19		nC
Q _{g(th)}	Gate charge at V _{th}			0.15		nC
Q _{oss}	Output charge	V _{DS} = 6 V, V _{GS} = 0 V		0.81		nC
t _{d(on)}	Turnon delay time			4		ns
t _r	Rise time	V _{DS} = 6 V, V _{GS} = 4.5 V,		4		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 0.4 \text{ A}, R_G = 2 \Omega$		11		ns
t _f	Fall time			3		ns
DIODE (CHARACTERISTICS					
V _{SD}	Diode forward voltage	I _{SD} = 0.4 A, V _{GS} = 0 V		0.71	1	V
Q _{rr}	Reverse recovery charge	V _{DS} = 6 V, I _E = 0.4 A, di/dt = 100 A/µs		2.1		nC
t _{rr}	Reverse recovery time	ν _{DS} - σ ν, ι _F - υ.4 Α, αι/αι - 100 Α/μs		8		ns

5.2 Thermal Information

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
D	Junction-to-ambient thermal resistance ⁽¹⁾		90		°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽²⁾		255		C/VV

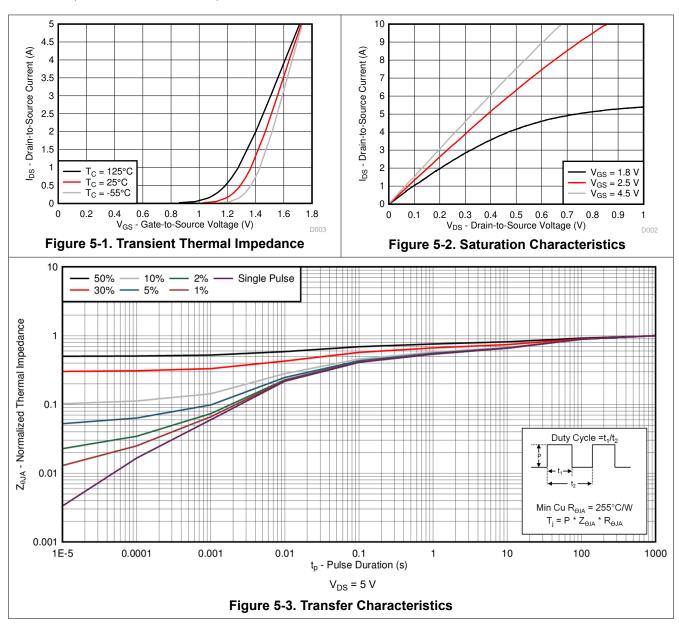
⁽¹⁾ Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.

⁽²⁾ Device mounted on FR4 material with minimum Cu mounting area.

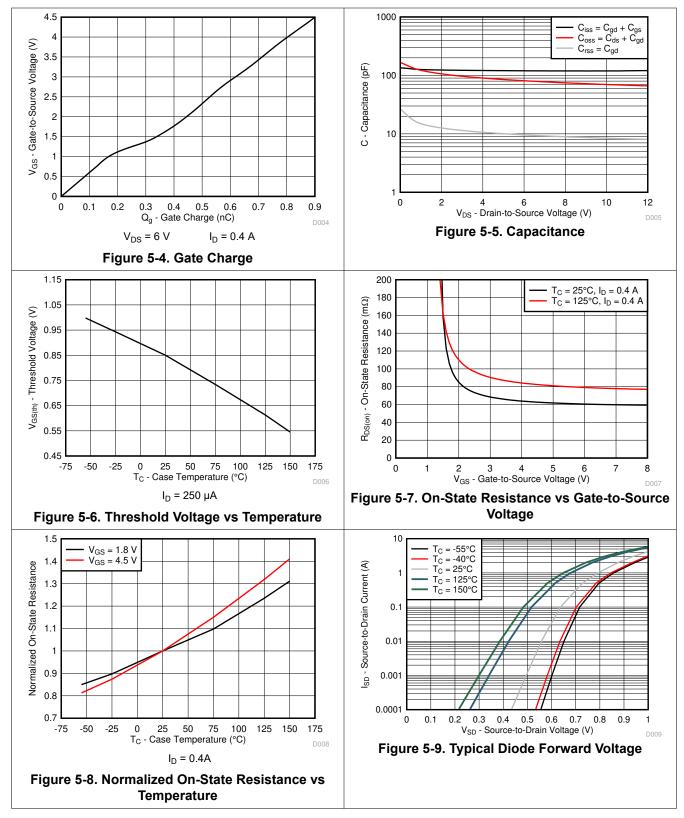


5.3 Typical MOSFET Characteristics

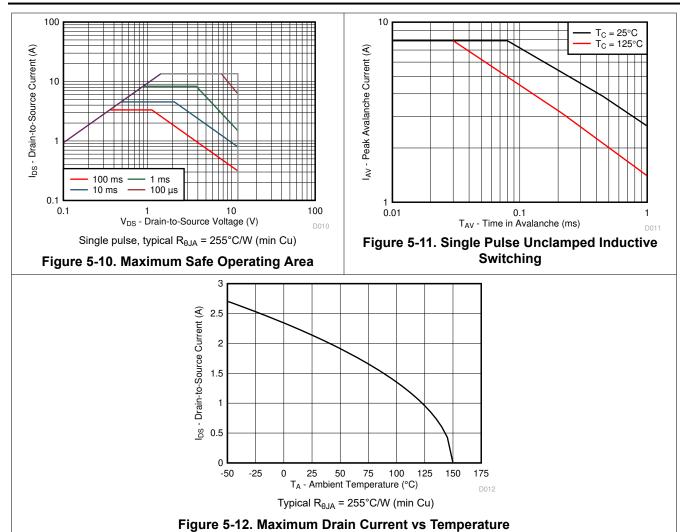
 $T_A = 25$ °C (unless otherwise stated)



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6 Device and Documentation Support

6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

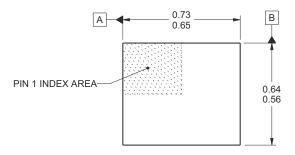
6.2 Trademarks

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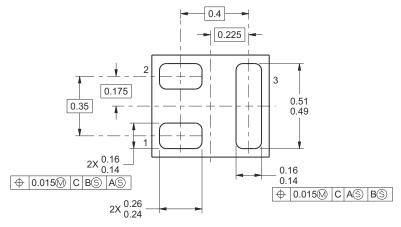
7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Mechanical Dimensions







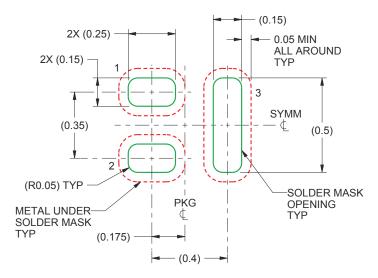
- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.

Table 7-1. Pin Configuration

POSITION	DESIGNATION
Pin 1	Gate
Pin 2	Source
Pin 3	Drain

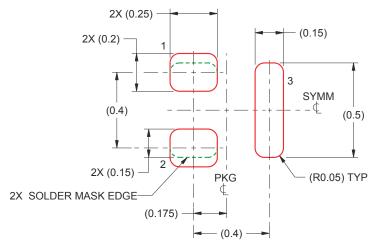
Submit Document Feedback

7.2 Recommended Minimum PCB Layout



- A. All dimensions are in millimeters.
- A. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

7.3 Recommended Stencil Pattern



A. All dimensions are in millimeters.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD13380F3	ACTIVE	PICOSTAR	YJM	3	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	D	Samples
CSD13380F3T	ACTIVE	PICOSTAR	YJM	3	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	D	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

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PACKAGE MATERIALS INFORMATION

www.ti.com 20-Apr-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13380F3	ICOSTAF	YJM	3	3000	180.0	8.4	1.94	0.79	0.44	4.0	8.0	Q2
CSD13380F3T	ICOSTAF	YJM	3	250	180.0	8.4	1.94	0.79	0.44	4.0	8.0	Q2

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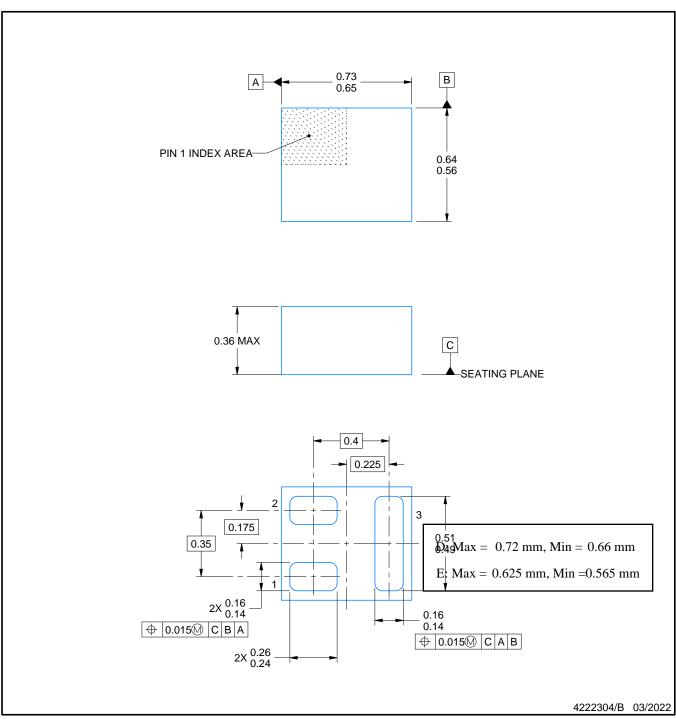


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13380F3	PICOSTAR	YJM	3	3000	182.0	182.0	20.0
CSD13380F3T	PICOSTAR	YJM	3	250	182.0	182.0	20.0



PicoStar™



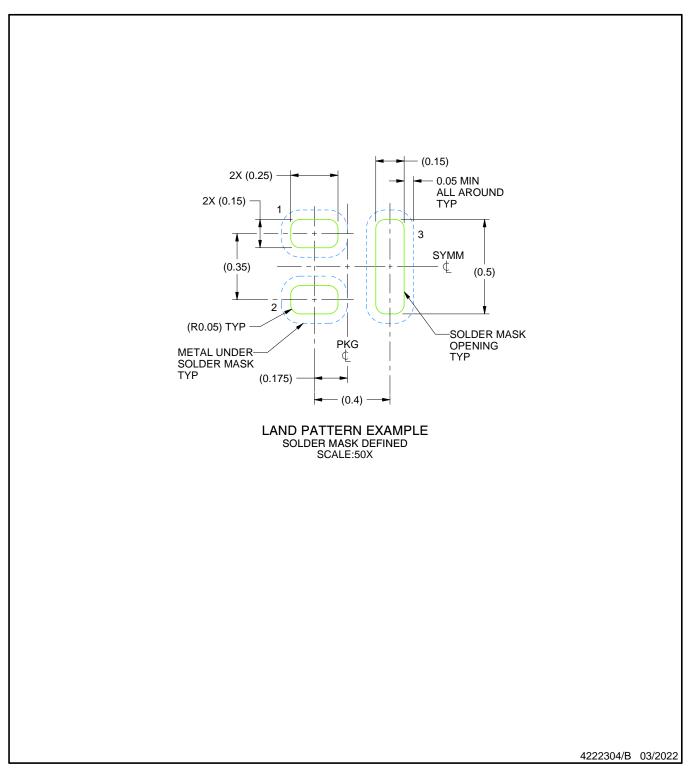
NOTES:

PicoStar is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M
 2. This drawing is subject to change without notice.
- This drawing is subject to charge without notice.
 This package is a Pb-free bump design. Bump finish may vary. To determine the exact finish, refer to the device datasheet or contact a local TI representative.



PicoStar™

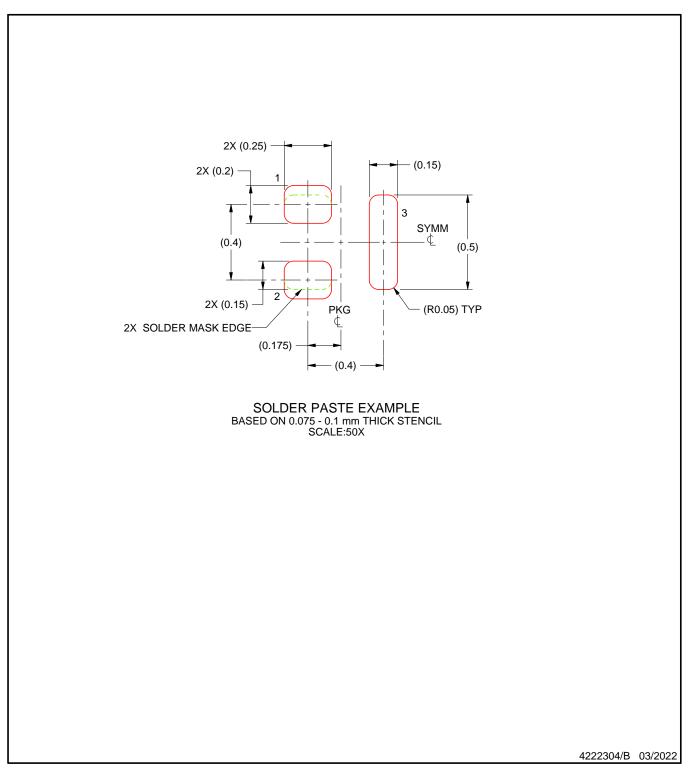


NOTES: (continued)

4. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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